Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/827,150	CHANG ET AL.	
Examiner	Art Unit	
Quang N. Vo	2625	

SEARCHED				
Class	Subclass	Date	Examiner	
358	3.03	6/28/2007	QV	
358	3.06	6/28/2007	QV	
358	1.9	7/2/2007	QV	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1			

SEARCH NOT (INCLUDING SEARCH		)
9	DATE	EXMR
US Pat, US PG Pub, USOCR, EPO, JPO, DERWENT, IBM	6/28/2007	QV
Inventor Name Search, see attachment	6/28/2007	QV